

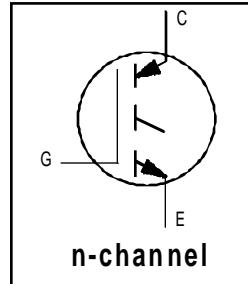
## INSULATED GATE BIPOLAR TRANSISTOR

### Features

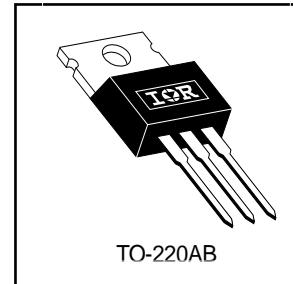
- Designed expressly for Switch-Mode Power Supply and PFC (power factor correction) applications
- Industry-benchmark switching losses improve efficiency of all power supply topologies
- 50% reduction of Eoff parameter
- Low IGBT conduction losses
- Latest-generation IGBT design and construction offers tighter parameters distribution, exceptional reliability

### Benefits

- Lower switching losses allow more cost-effective operation than power MOSFETs up to 150 kHz ("hard switched" mode)
- Of particular benefit to single-ended converters and boost PFC topologies 150W and higher
- Low conduction losses and minimal minority-carrier recombination make these an excellent option for resonant mode switching as well (up to >>300 kHz)



$V_{CES} = 600V$
$V_{CE(on)} \text{ max.} = 2.70V$
@ $V_{GE} = 15V$ , $I_C = 12A$



### Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Breakdown Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	23	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	12	
$I_{CM}$	Pulsed Collector Current ①	92	
$I_{LM}$	Clamped Inductive Load Current ②	92	
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	V
$E_{AVR}$	Reverse Voltage Avalanche Energy ③	180	mJ
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	100	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	42	
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 150	°C
	Soldering Temperature, for 10 seconds	300 (0.063 in. (1.6mm from case))	
	Mounting torque, 6-32 or M3 screw.	10 lbf·in (1.1N·m)	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	1.2	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	80	
$Wt$	Weight	1.44	—	g

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

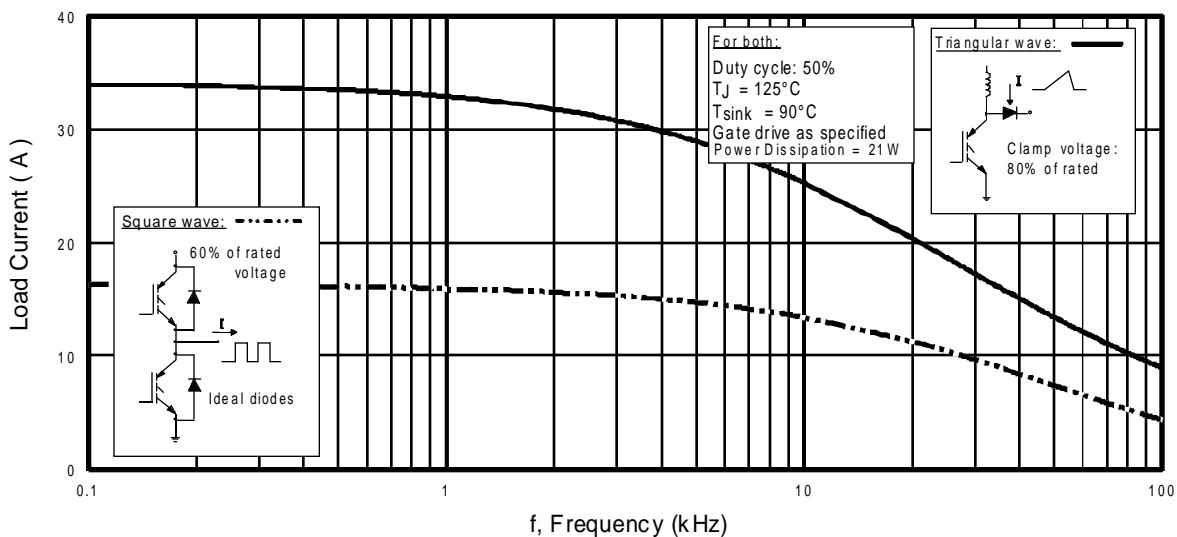
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{CES}}$	Collector-to-Emitter Breakdown Voltage	600	—	—	V	$V_{\text{GE}} = 0\text{V}, I_C = 250\mu\text{A}$
$V_{(\text{BR})\text{ECS}}$	Emitter-to-Collector Breakdown Voltage ④	18	—	—	V	$V_{\text{GE}} = 0\text{V}, I_C = 1.0\text{A}$
$\Delta V_{(\text{BR})\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	—	0.34	—	$\text{V}/^\circ\text{C}$	$V_{\text{GE}} = 0\text{V}, I_C = 1.0\text{mA}$
$V_{\text{CE}(\text{ON})}$	Collector-to-Emitter Saturation Voltage	—	2.1	2.7	V	$I_C = 12\text{A}$ $V_{\text{GE}} = 15\text{V}$
		—	2.45	—		$I_C = 23\text{A}$ See Fig.2, 5
		—	1.95	—		$I_C = 12\text{A}, T_J = 150^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	3.0	—	6.0		$V_{\text{CE}} = V_{\text{GE}}, I_C = 250\mu\text{A}$
$\Delta V_{\text{GE}(\text{th})/\Delta T_J}$	Temperature Coeff. of Threshold Voltage	—	-11	—	$\text{mV}/^\circ\text{C}$	$V_{\text{CE}} = V_{\text{GE}}, I_C = 250\mu\text{A}$
$g_{\text{fe}}$	Forward Transconductance ⑤	11	16	—	S	$V_{\text{CE}} = 100\text{ V}, I_C = 12\text{A}$
$I_{\text{CES}}$	Zero Gate Voltage Collector Current	—	—	250	$\mu\text{A}$	$V_{\text{GE}} = 0\text{V}, V_{\text{CE}} = 600\text{V}$
		—	—	2.0		$V_{\text{GE}} = 0\text{V}, V_{\text{CE}} = 10\text{V}, T_J = 25^\circ\text{C}$
		—	—	1000		$V_{\text{GE}} = 0\text{V}, V_{\text{CE}} = 600\text{V}, T_J = 150^\circ\text{C}$
$I_{\text{GES}}$	Gate-to-Emitter Leakage Current	—	—	$\pm 100$	nA	$V_{\text{GE}} = \pm 20\text{V}$

**Switching Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

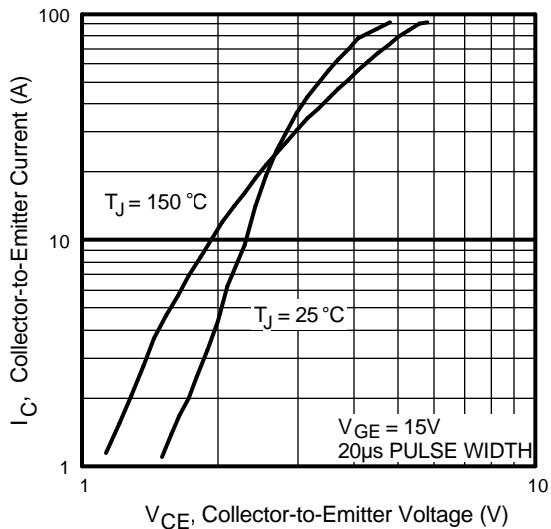
	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge (turn-on)	—	51	76	nC	$I_C = 12\text{A}$
$Q_{\text{ge}}$	Gate - Emitter Charge (turn-on)	—	7.6	11		$V_{\text{CC}} = 400\text{V}$ See Fig.8
$Q_{\text{gc}}$	Gate - Collector Charge (turn-on)	—	18	27		$V_{\text{GE}} = 15\text{V}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	25	—	ns	$T_J = 25^\circ\text{C}$ $I_C = 12\text{A}, V_{\text{CC}} = 480\text{V}$ $V_{\text{GE}} = 15\text{V}, R_G = 23\Omega$ Energy losses include "tail" See Fig. 9, 10, 13, 14
$t_r$	Rise Time	—	16	—		
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	99	150		
$t_f$	Fall Time	—	67	100		
$E_{\text{on}}$	Turn-On Switching Loss	—	0.13	—	mJ	Energy losses include "tail" See Fig. 9, 10, 13, 14
$E_{\text{off}}$	Turn-Off Switching Loss	—	0.13	—		
$E_{\text{ts}}$	Total Switching Loss	—	0.26	0.35		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	24	—	ns	$T_J = 150^\circ\text{C},$ $I_C = 12\text{A}, V_{\text{CC}} = 480\text{V}$ $V_{\text{GE}} = 15\text{V}, R_G = 23\Omega$ Energy losses include "tail" See Fig. 11, 13, 14
$t_r$	Rise Time	—	17	—		
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	150	—		
$t_f$	Fall Time	—	150	—		
$E_{\text{ts}}$	Total Switching Loss	—	0.55	—	mJ	See Fig. 11, 13, 14
$L_E$	Internal Emitter Inductance	—	7.5	—	nH	Measured 5mm from package
$C_{\text{ies}}$	Input Capacitance	—	980	—	pF	$V_{\text{GE}} = 0\text{V}$ $V_{\text{CC}} = 30\text{V}$ See Fig. 7 $f = 1.0\text{MHz}$
$C_{\text{oes}}$	Output Capacitance	—	71	—		
$C_{\text{res}}$	Reverse Transfer Capacitance	—	18	—		

**Notes:**

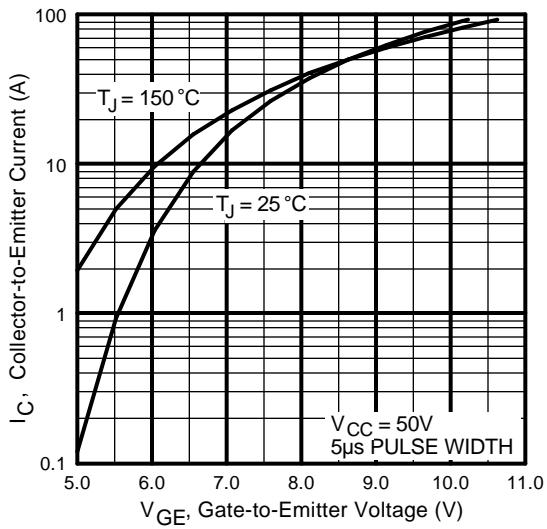
- ① Repetitive rating;  $V_{\text{GE}} = 20\text{V}$ , pulse width limited by max. junction temperature. ( See fig. 13b )
- ②  $V_{\text{CC}} = 80\%(V_{\text{CES}})$ ,  $V_{\text{GE}} = 20\text{V}$ ,  $L = 10\mu\text{H}$ ,  $R_G = 23\Omega$ , ( See fig. 13a )
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- ④ Pulse width  $\leq 80\mu\text{s}$ ; duty factor  $\leq 0.1\%$ .
- ⑤ Pulse width  $5.0\mu\text{s}$ , single shot.



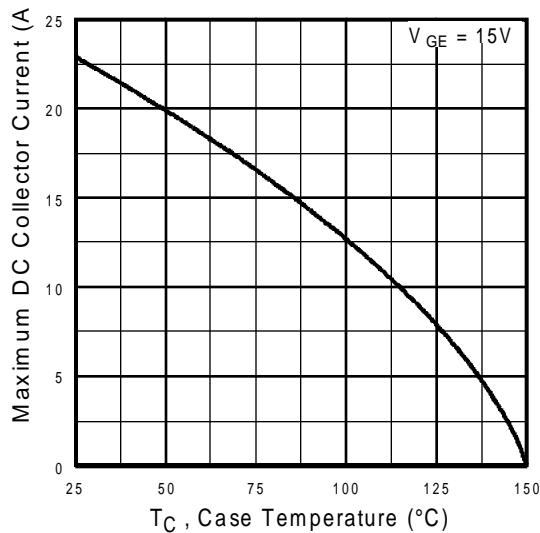
**Fig. 1 - Typical Load Current vs. Frequency**  
(For square wave,  $I=I_{RMS}$  of fundamental; for triangular wave,  $I=I_{PK}$ )



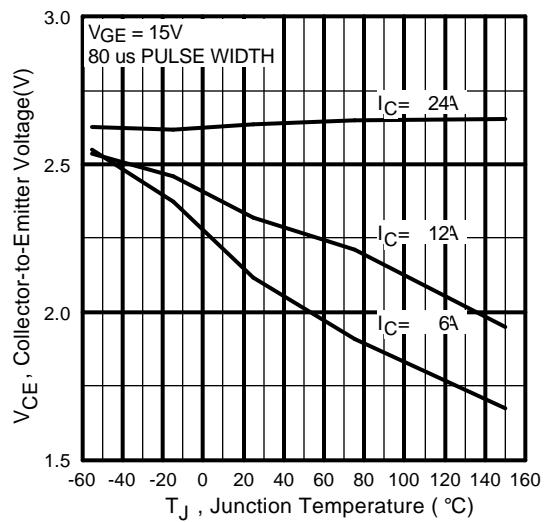
**Fig. 2 - Typical Output Characteristics**



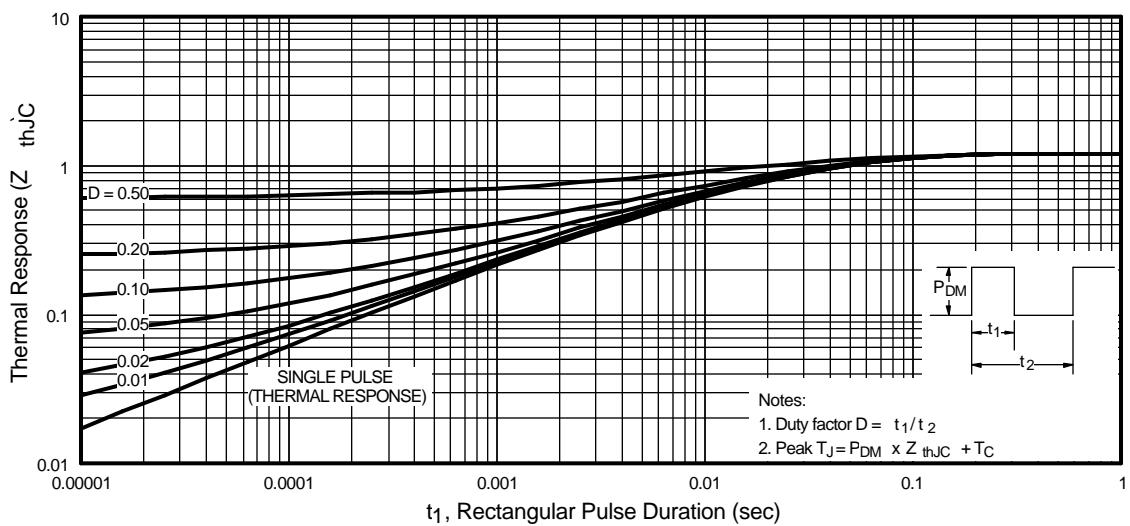
**Fig. 3 - Typical Transfer Characteristics**



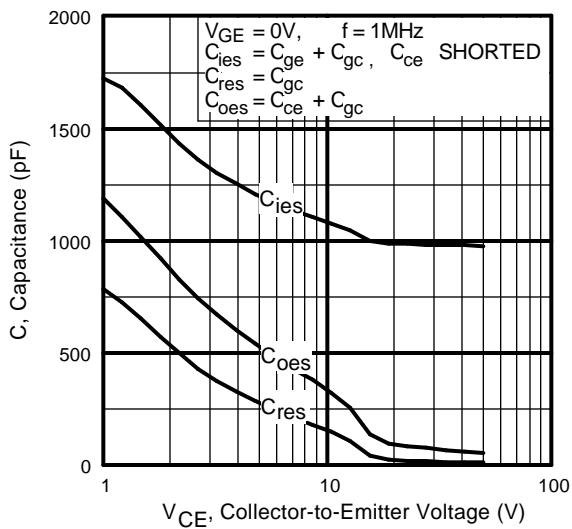
**Fig. 4 - Maximum Collector Current vs. Case Temperature**



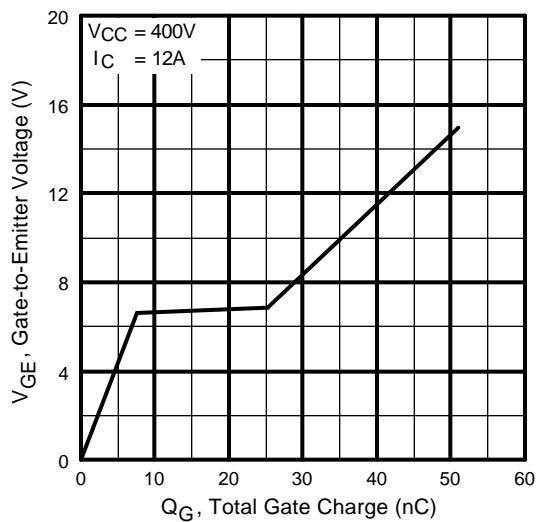
**Fig. 5 - Collector-to-Emitter Voltage vs. Junction Temperature**



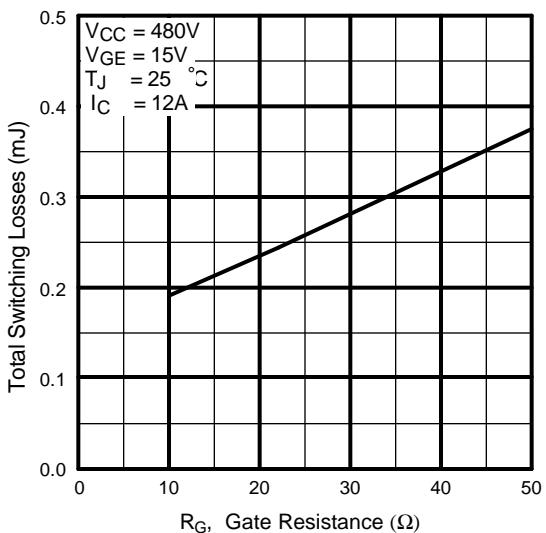
**Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**



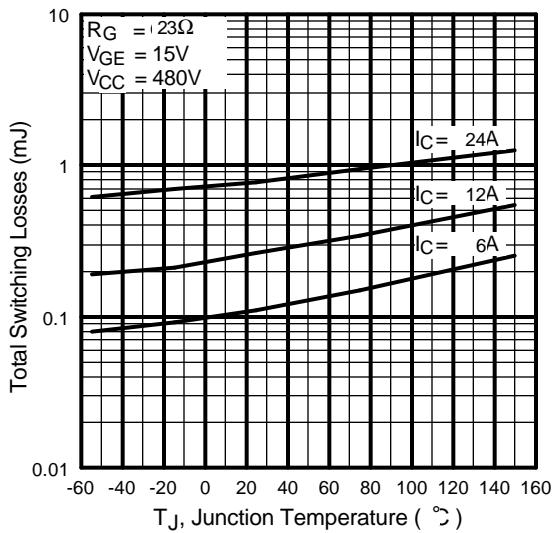
**Fig. 7** - Typical Capacitance vs.  
Collector-to-Emitter Voltage



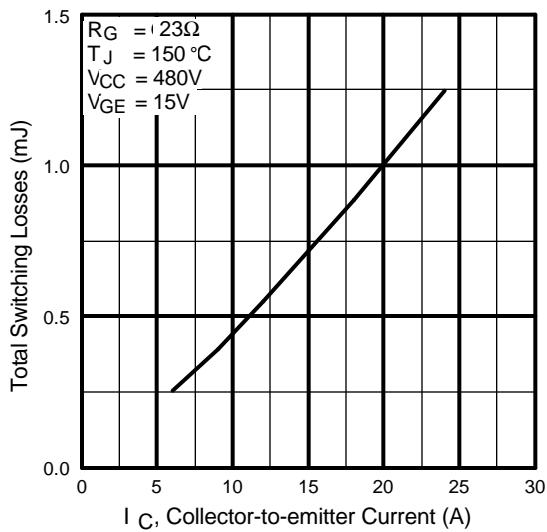
**Fig. 8** - Typical Gate Charge vs.  
Gate-to-Emitter Voltage



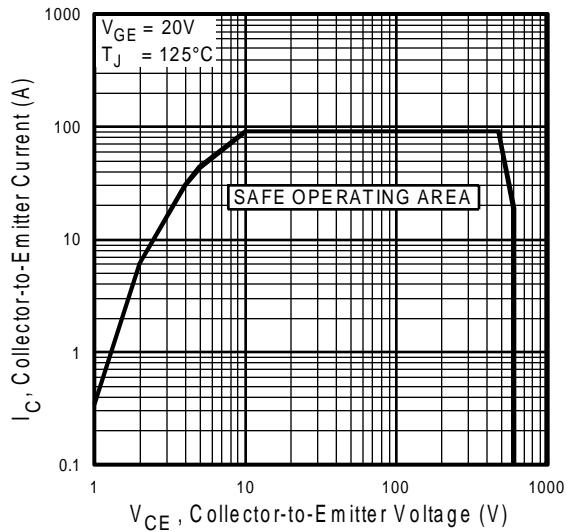
**Fig. 9** - Typical Switching Losses vs. Gate  
Resistance



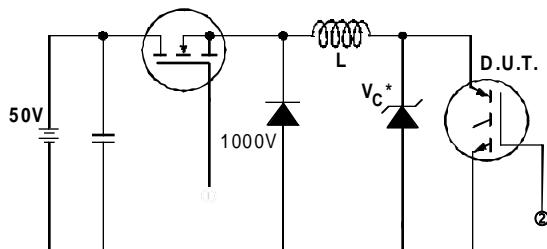
**Fig. 10** - Typical Switching Losses vs.  
Junction Temperature



**Fig. 11 - Typical Switching Losses vs.  
Collector-to-Emitter Current**

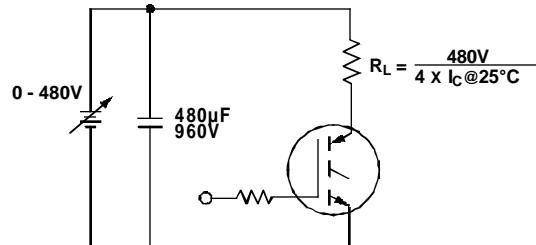


**Fig. 12 - Turn-Off SOA**

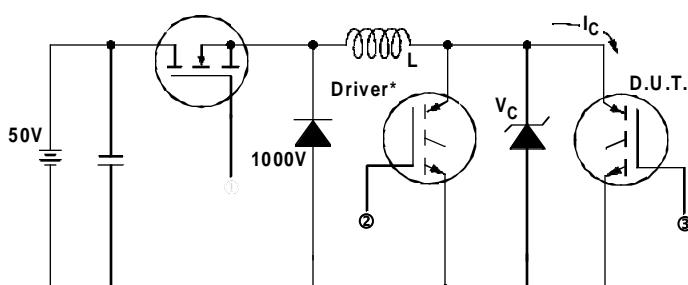


\* Driver same type as D.U.T.;  $V_C = 80\%$  of  $V_{ce(max)}$   
\* Note: Due to the 50V power supply, pulse width and inductor will increase to obtain rated  $I_d$ .

**Fig. 13a - Clamped Inductive Load Test Circuit**

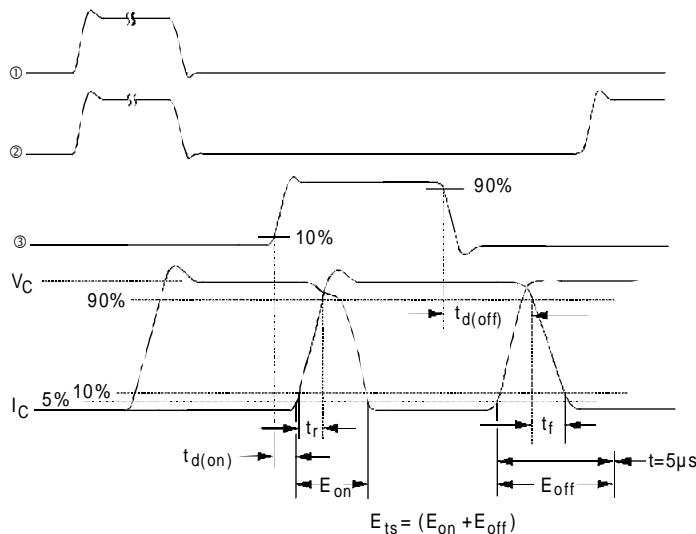


**Fig. 13b - Pulsed Collector Current Test Circuit**



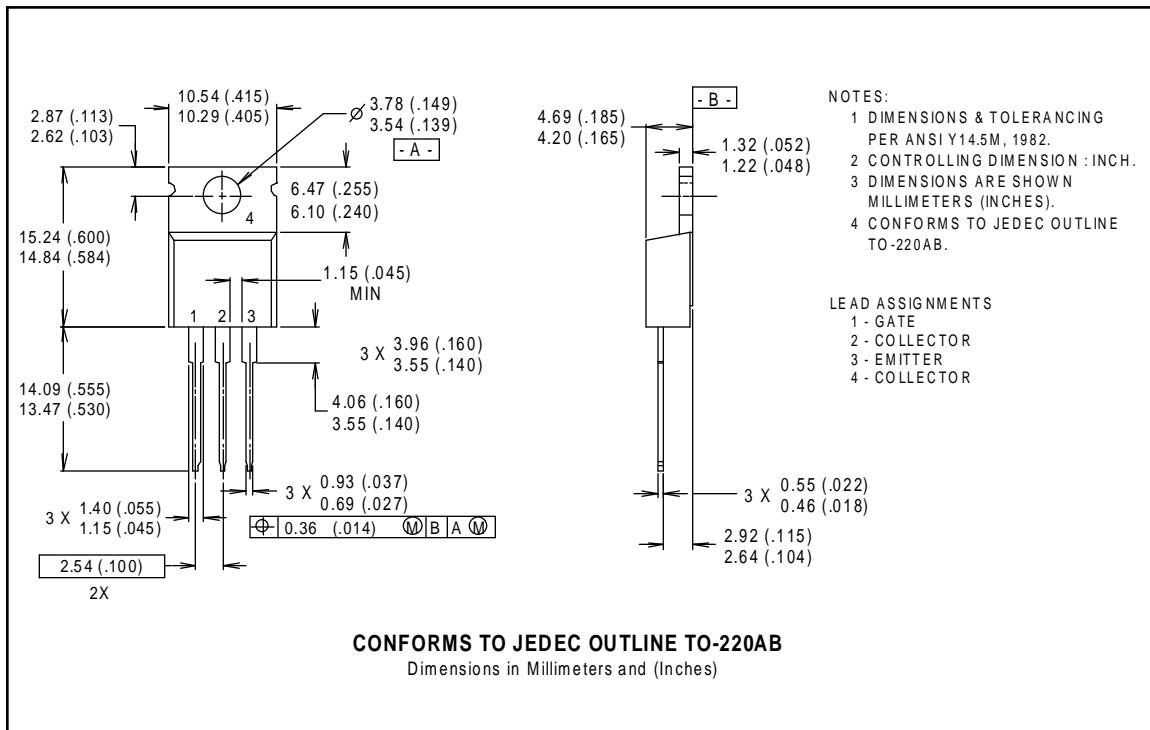
**Fig. 14a - Switching Loss Test Circuit**

\* Driver same type as D.U.T.,  $V_C = 480V$



**Fig. 14b - Switching Loss Waveforms**

## Case Outline and Dimensions — TO-220AB



International  
**IR** Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

**EUROPEAN HEADQUARTERS:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

**IR CANADA:** 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897

**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

**IR FAR EAST:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

**IR SOUTHEAST ASIA:** 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

<http://www.irf.com/> Data and specifications subject to change without notice. 7/97